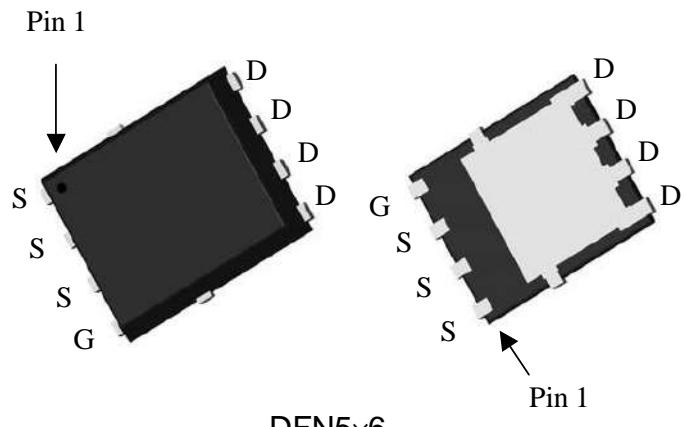


P-Channel Enhancement Mode Power MOSFET

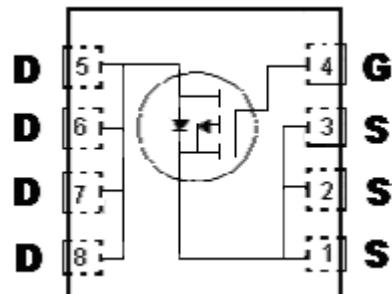
Features:

- Single Drive Requirement
- Low On-resistance
- Fast Switching Characteristic
- Pb-free lead plating and Halogen-free package

BVdss	-30V
Id@VGS=-10V, Tc=25°C	-59A
Id@VGS=-10V, TA=25°C	-19.5A
RDS(on)(TYP)	VGS=-10V, Id=-20A VGS=-4.5V, Id=-12A
	7.3mΩ 12mΩ



DFN5x6



G : Gate D : Drain S : Source

Ordering Information

Device	Package	Shipping
KWB9D0P03H8	DFN5x6 (Pb-free lead plating and halogen-free package)	3000 pcs / Tape & Reel

Absolute Maximum Ratings ($T_a=25^\circ C$)

Parameter	Symbol	10s	Steady State	Unit
Drain-Source Voltage	V_{DS}	-30	V	
Gate-Source Voltage	V_{GS}	± 20		
Continuous Drain Current @ $T_c=25^\circ C$, $V_{GS}=-10V$ (Note1)	I_D	-59	A	
Continuous Drain Current @ $T_c=100^\circ C$, $V_{GS}=-10V$ (Note1)		-37.3		
Continuous Drain Current @ $T_a=25^\circ C$, $V_{GS}=-10V$ (Note2)	I_{DSM}	-19.5	-11.6	
Continuous Drain Current @ $T_a=70^\circ C$, $V_{GS}=-10V$ (Note2)		-15.6	-9.3	
Pulsed Drain Current	I_{DM}	-210	A	
Avalanche Current @ $L=0.1mH$	I_{AS}	-34		
Avalanche Energy @ $L=1mH$, $I_D=-16A$, $V_{DD}=-15V$ (Note4)	E_{AS}	128	mJ	
Total Power Dissipation	P_D	60	W	
		24		
	P_{DSM}	6.5	2.3	
		4.5	1.6	
Operating Junction and Storage Temperature Range	T_j , T_{stg}	-55~+150	$^\circ C$	

Thermal Data

Parameter	Symbol	Typical	Maximum	Unit
Thermal Resistance, Junction-to-case	$R_{th,j-c}$	2.2	2.5	
Thermal Resistance, Junction-to-ambient (Note2)	$R_{th,j-a}$	18	23	$^\circ C/W$
		50	65	

- Note : 1. The power dissipation P_D is based on $T_{j(MAX)}=150^\circ C$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
2. The value of $R_{\theta JA}$ is measured with the device mounted on 1 in² FR-4 board with 2 oz. copper, in a still air environment with $T_a=25^\circ C$. The power dissipation P_{DSM} is based on $R_{\theta JA}$ and the maximum allowed junction temperature of $150^\circ C$. The value in any given application depends on the user's specific board design.
3. Pulse width limited by junction temperature $T_{j(MAX)}=150^\circ C$.
4. Ratings are based on low frequency and low duty cycles to keep initial $T_j=25^\circ C$. 100% tested by conditions of $L=0.1mH$, $I_{AS}=-10A$, $V_{GS}=-10V$, $V_{DD}=-15V$.

Characteristics ($T_c=25^\circ C$, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV_{DSS}	-30	-	-	V	$V_{GS}=0V$, $I_D=-250\mu A$
$V_{GS(th)}$	-1	-	-2.5		$V_{DS} = V_{GS}$, $I_D=-250\mu A$
G_{FS} *1	-	14.7	-	S	$V_{DS}=-10V$, $I_D=-5A$
I_{GSS}	-	-	± 100	nA	$V_{GS}=\pm 20V$, $V_{DS}=0V$
ID_{SS}	-	-	-1	μA	$V_{DS}=-24V$, $V_{GS}=0V$
	-	-	-10		$V_{DS}=-24V$, $V_{GS}=0$, $T_j=70^\circ C$
$R_{DS(ON)}$ *1	-	7.3	10	$m\Omega$	$V_{GS}=-10V$, $I_D=-20A$
	-	12	17		$V_{GS}=-4.5V$, $I_D=-12A$

Dynamic *4					
C _{iss}	-	2177	-	pF	V _{DS} =-25V, V _{GS} =0V, f=1MHz
C _{oss}	-	235	-		
C _{rss}	-	171	-		
Q _g *1, 2	-	49.6	-	nC	V _{DS} =-15V, V _{GS} =-10V, I _D =-12A
Q _{gs} *1, 2	-	7.3	-		
Q _{gd} *1, 2	-	11.4	-		
t _{d(ON)} *1, 2	-	14.6	-		
t _r *1, 2	-	22.6	-		
t _{d(OFF)} *1, 2	-	72.6	-	ns	V _{DS} =-15V, I _D =-12A, V _{GS} =-10V R _G =1Ω
t _f *1, 2	-	16.4	-		
R _g	-	4	-	Ω	f=1MHz
Source-Drain Diode					
I _S *1	-	-	-50	A	
I _{SM} *3	-	-	-200		
V _{SD} *1	-	-0.87	-1.2	V	I _S =-20A, V _{GS} =0V
trr	-	32.3	-	ns	
Qrr	-	12.9	-	nC	I _F =-1A, dI _F /dt=100A/μs

Note : *1.Pulse Test : Pulse Width≤300μs, Duty Cycle≤2%

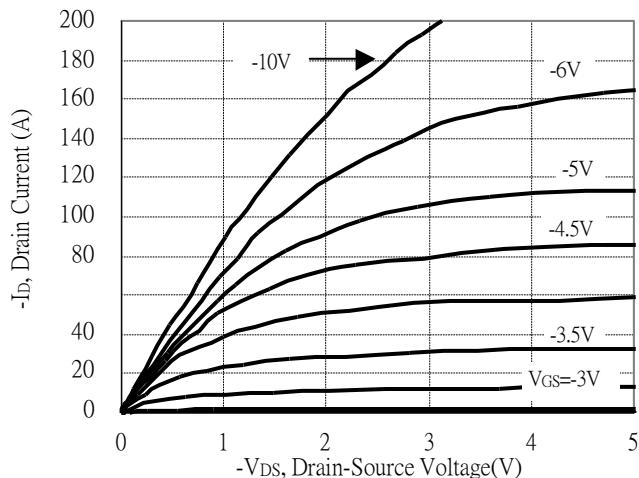
*2.Independent of operating temperature

*3.Pulse width limited by maximum junction temperature.

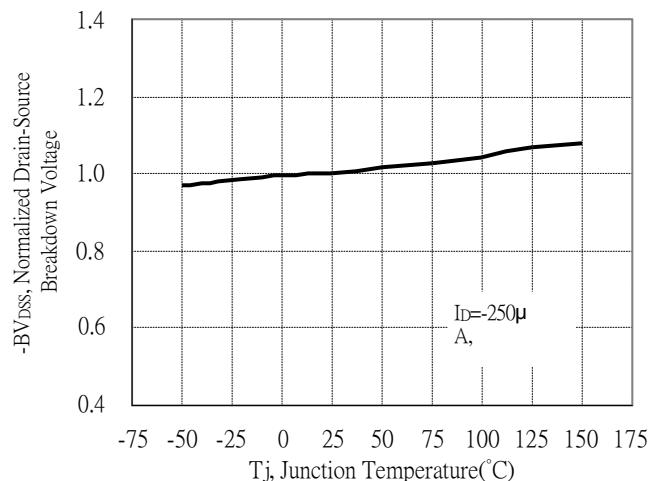
*4.Guaranteed by design, not subject to production testing.

Typical Characteristics

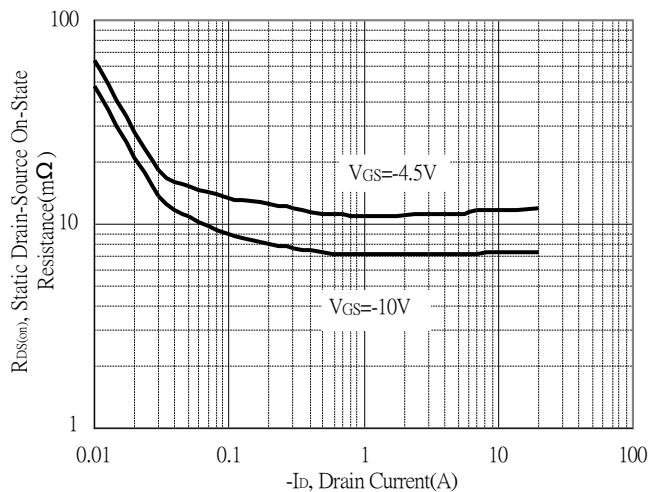
Typical Output Characteristics



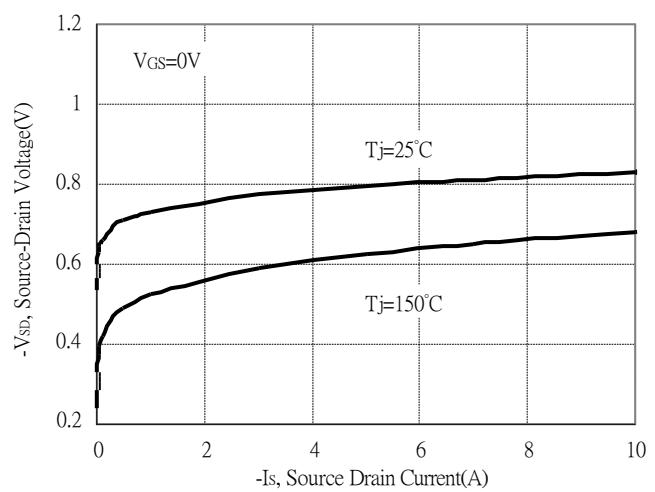
Breakdown Voltage vs Ambient Temperature



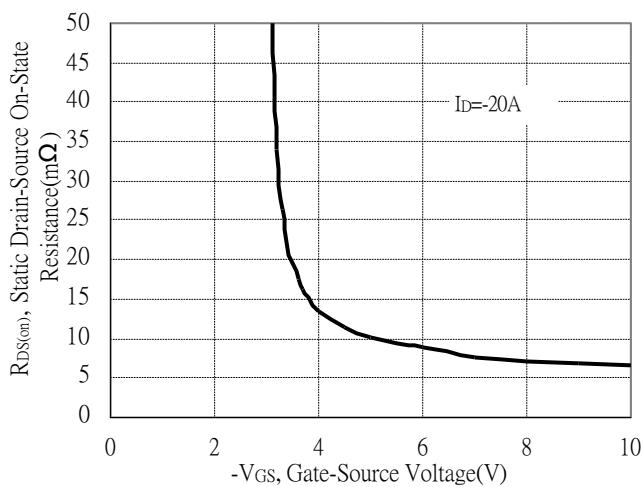
Static Drain-Source On-State resistance vs Drain Current



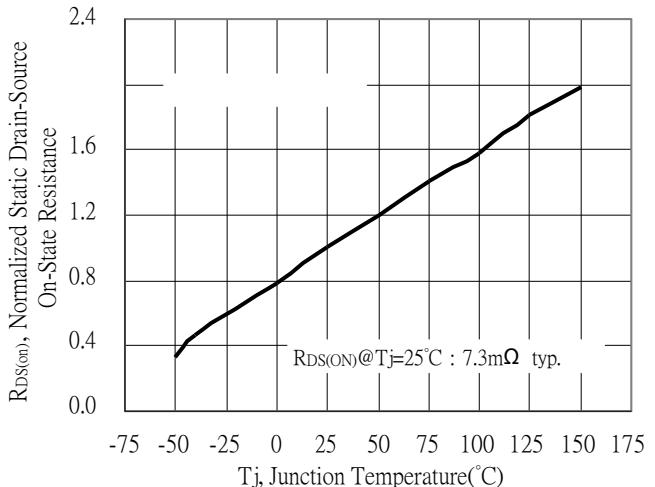
Source Drain Current vs Source-Drain Voltage



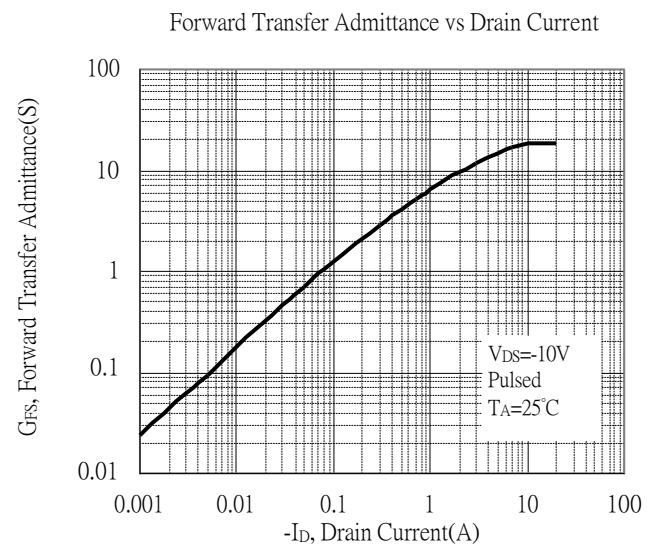
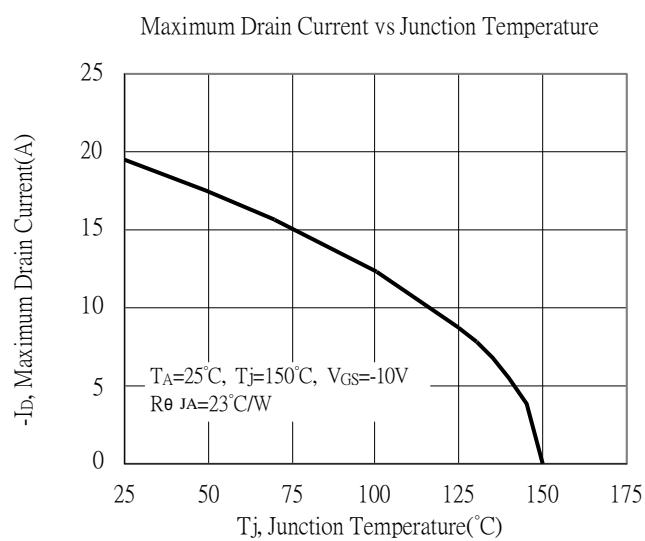
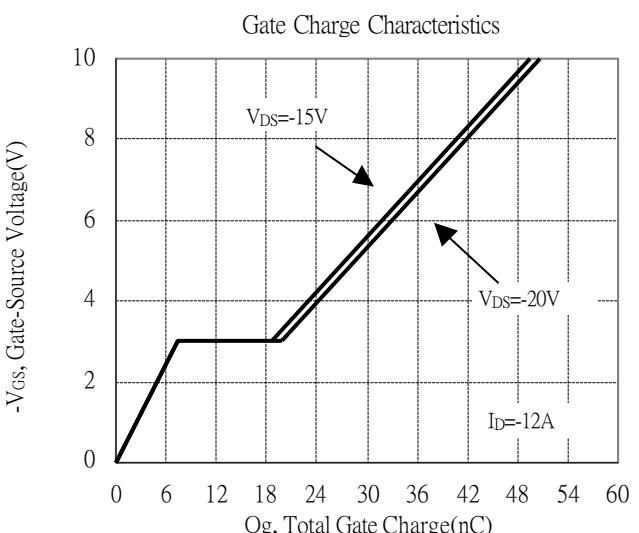
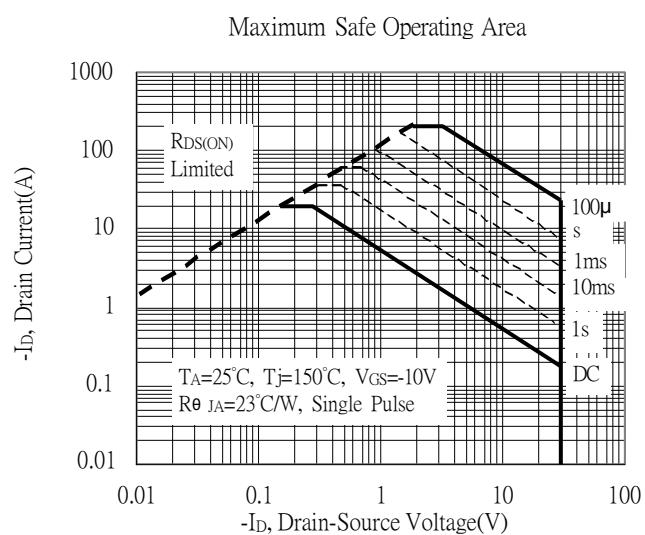
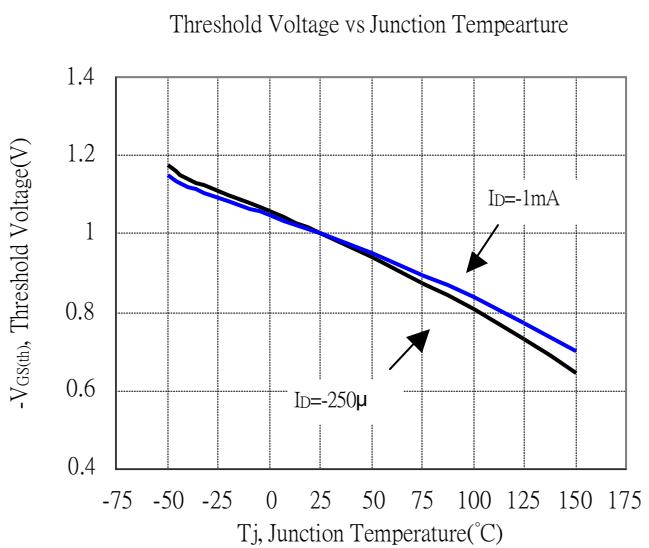
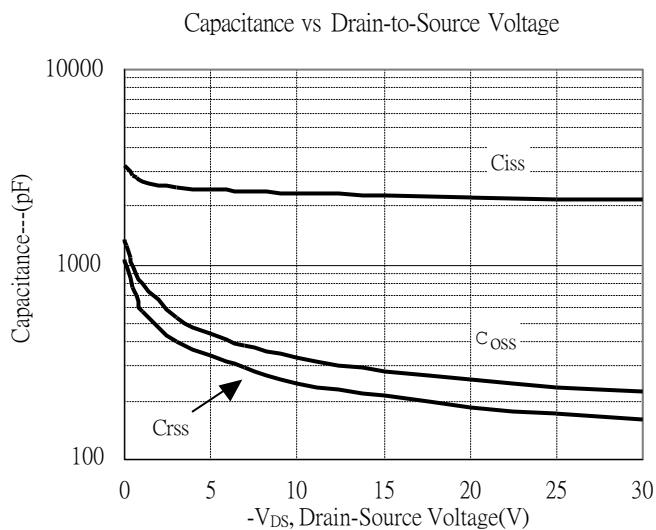
Static Drain-Source On-State Resistance vs Gate-Source



Drain-Source On-State Resistance vs Junction Temperature

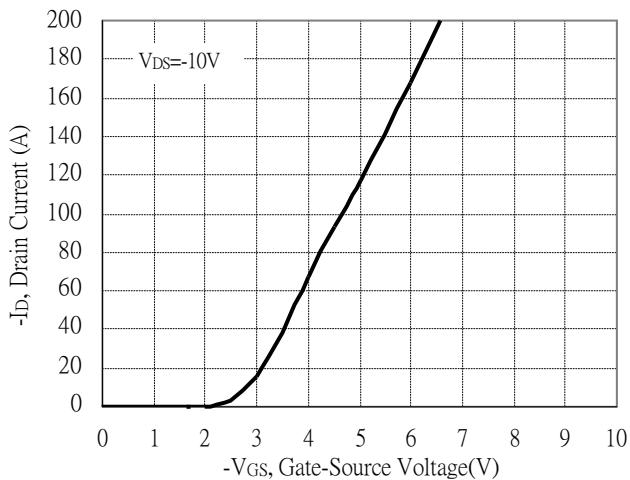


Typical Characteristics(Cont.)

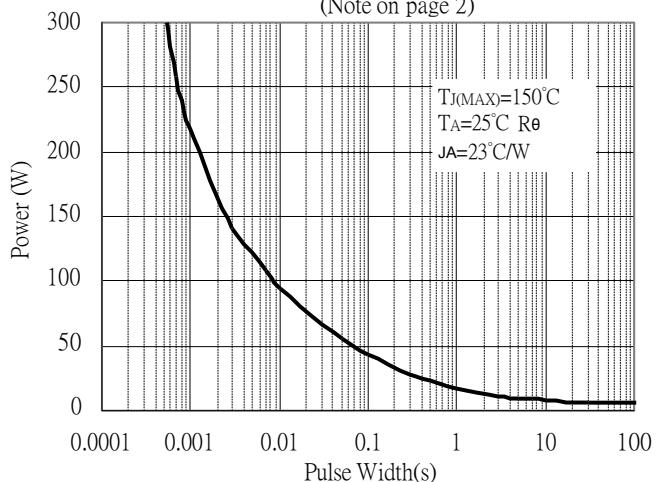


Typical Characteristics(Cont.)

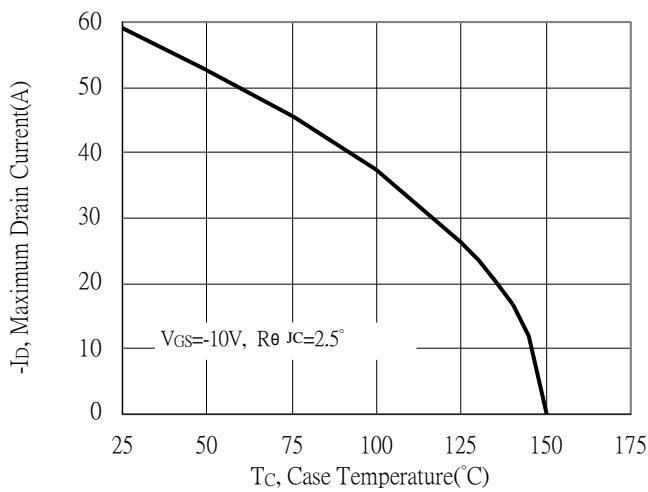
Typical Transfer Characteristics



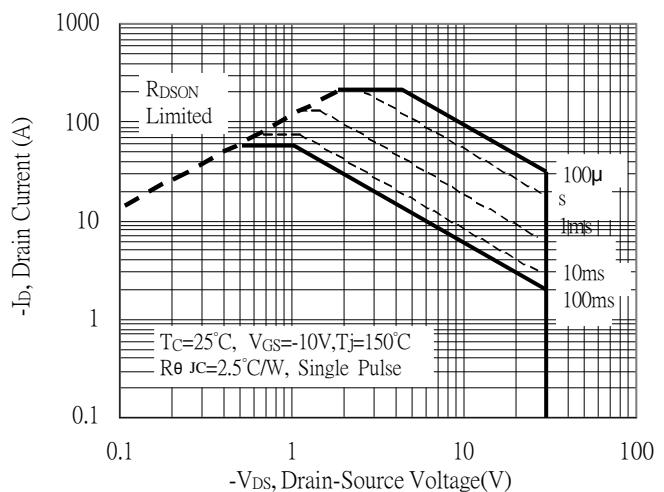
Single Pulse Power Rating, Junction to Ambient
 (Note on page 2)



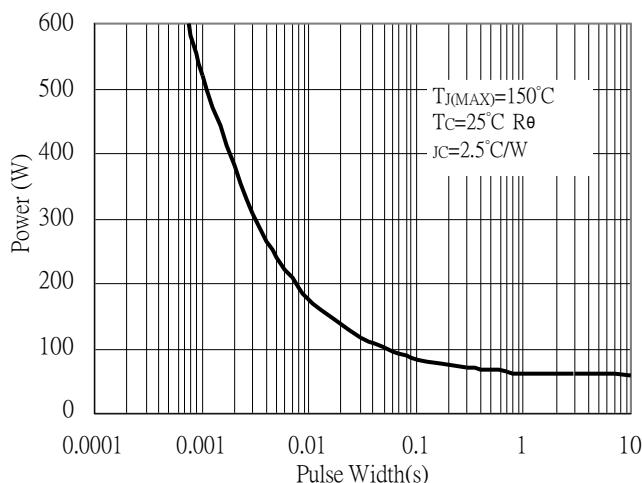
Maximum Drain Current vs Case Temperature



Maximum Safe Operating Area

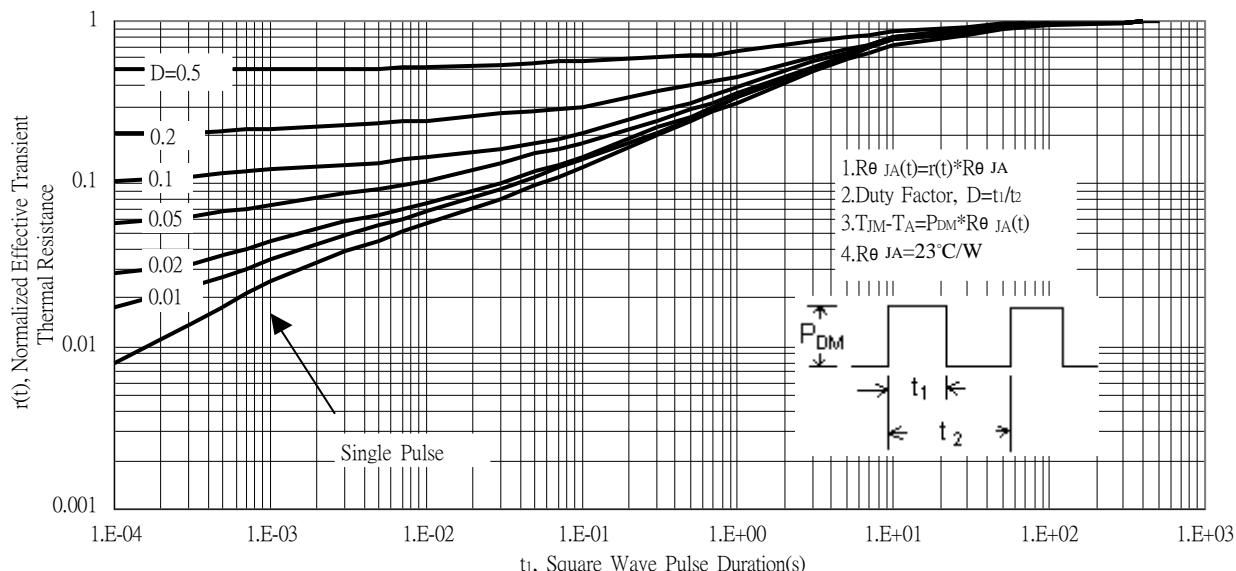


Single Pulse Maximum Power Dissipation

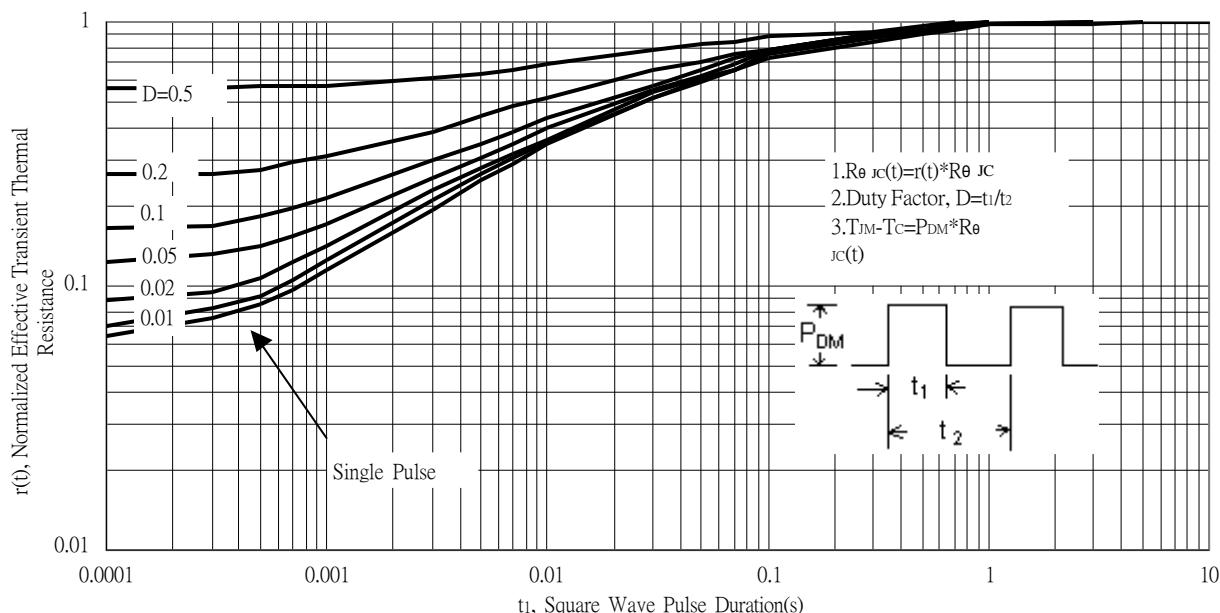


Typical Characteristics(Cont.)

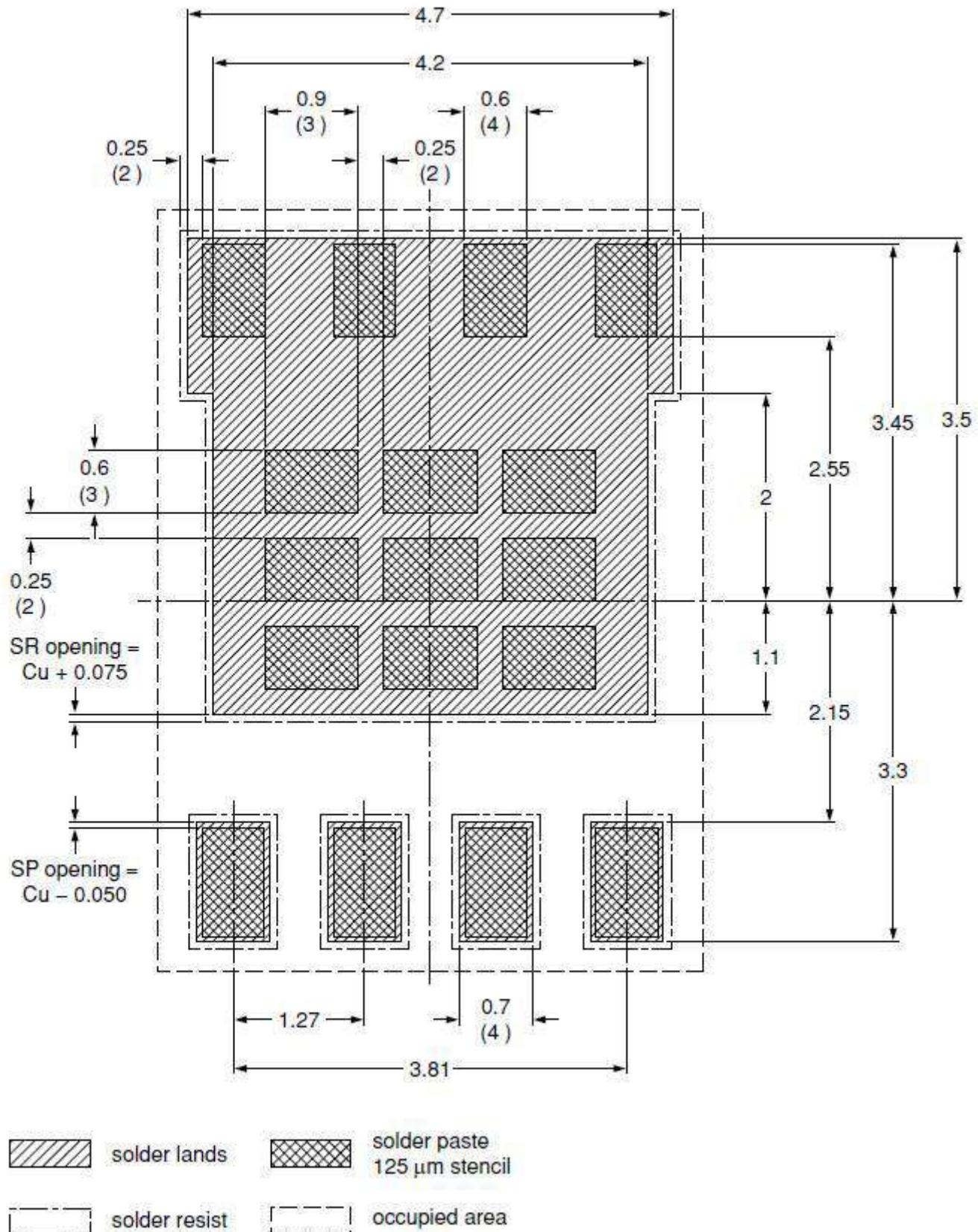
Transient Thermal Response Curves



Transient Thermal Response Curves

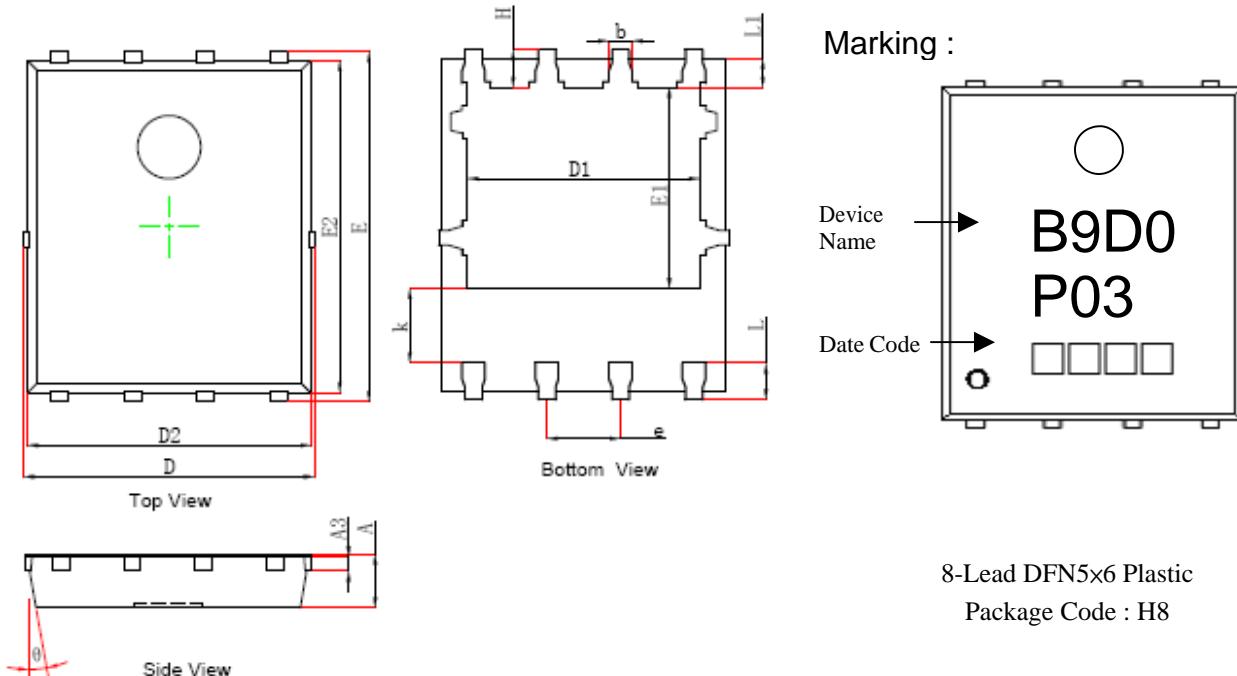


Recommended Soldering Footprint & Stencil Design



unit : mm

DFN5x6 Dimension



DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.900	1.000	0.035	0.039	k	1.190	1.390	0.047	0.055
A3	0.254	REF	0.010	REF	b	0.350	0.450	0.014	0.018
D	4.944	5.096	0.195	0.201	e	1.270	TYP.	0.050	TYP.
E	5.974	6.126	0.235	0.241	L	0.559	0.711	0.022	0.028
D1	3.910	4.110	0.154	0.162	L1	0.424	0.576	0.017	0.023
E1	3.375	3.575	0.133	0.141	H	0.574	0.726	0.023	0.029
D2	4.824	4.976	0.190	0.196	θ	10°	12°	10°	12°
E2	5.674	5.826	0.223	0.229					